

Notice of References Cited

Application/Control No.

10/713,790

Applicant(s)/Patent Under
Reexamination
PIER ET AL.

Examiner

S. Devi, Ph.D.

Art Unit

1645

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,157,443	01-2007	Joyce et al.	514/54
*	B	US-2,842,049	07-1958	DELANGRE JOHN P	430/199
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Maira-Litran et al. Infect. Immun. 73: 6752-6762, October 200
	V	Du Yuguo English abstract of Chinese patent application 0113648, published 417/02
	W	Defaye et al. English abstract of FR 2,640,628.
	X	Yang et al. Tetrahedron Lett. 43: 7561-7563, October 2002

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.